# MSKSEMI 美森科













ESD

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TSS

MOV

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PIFD

## **MMBT5551**

Product specification





#### TRANSISTOR (NPN)

#### **FEATURES**

- Complementary to MMBT5401
- Ideal for Medium Power Amplification and Switching

#### **Reference News**

PACKAGE OUTLINE		MARKING	
1 2	1. BASE 2. EMITTER 3.COLLECTOR	G1	
SOT-23			

#### MAXIMUM RATINGS (Ta=25℃ unless otherwise noted)

Symbol	Parameter	Value	Unit
V <sub>CBO</sub>	Collector-Base Voltage	180	V
V <sub>CEO</sub>	Collector-Emitter Voltage	160	V
V <sub>EBO</sub>	Emitter-Base Voltage	6	V
lc	Collector Current	600	mA
Pc	Collector Power Dissipation	300	mW
R. JA	Thermal Resistance From Junction To Ambient	416	°C/W
Tj	Junction Temperature	150	℃
T <sub>stg</sub>	Storage Temperature	-55∼+150	℃

### **ELECTRICAL CHARACTERISTICS (Ta=25℃ unless otherwise specified)**

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-base breakdown voltage	V <sub>(BR)</sub> CBO	lc=100μA, I <sub>E</sub> =0	180			V
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub> *	I <sub>C</sub> =1mA, I <sub>B</sub> =0	160			V
Emitter-base breakdown voltage	V <sub>(BR)EBO</sub>	I <sub>E</sub> =10μA, I <sub>C</sub> =0	6			V
Collector cut-off current	I <sub>CBO</sub>	V <sub>CB</sub> =120V, I <sub>E</sub> =0			50	nA
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =4V, I <sub>C</sub> =0			50	nA
DC current gain	h <sub>FE(1)</sub> *	V <sub>CE</sub> =5V, I <sub>C</sub> =1mA	80			
	h <sub>FE(2)</sub> *	V <sub>CE</sub> =5V, I <sub>C</sub> =10mA	100		300	
	h <sub>FE(3)</sub> *	V <sub>CE</sub> =5V, I <sub>C</sub> =50mA	50			
Collector-emitter saturation voltage	V <sub>CE(sat)1</sub> *	lc=10mA, I <sub>B</sub> =1mA			0.15	V
	V <sub>CE(sat)2</sub> *	I <sub>C</sub> =50mA, I <sub>B</sub> =5mA			0.2	V
Base-emitter saturation voltage	V <sub>BE(sat)1</sub> *	lc=10mA, I <sub>B</sub> =1mA			1	V
	V <sub>BE(sat)2</sub> *	lc=50mA, I <sub>B</sub> =5mA			1	V
Transition frequency	f⊤	V <sub>CE</sub> =10V,I <sub>C</sub> =10mA, f=100MHz	100		300	MHz
Collector output capacitance	C <sub>ob</sub>	V <sub>CB</sub> =10V, I <sub>E</sub> =0, f=1MHz			6	pF

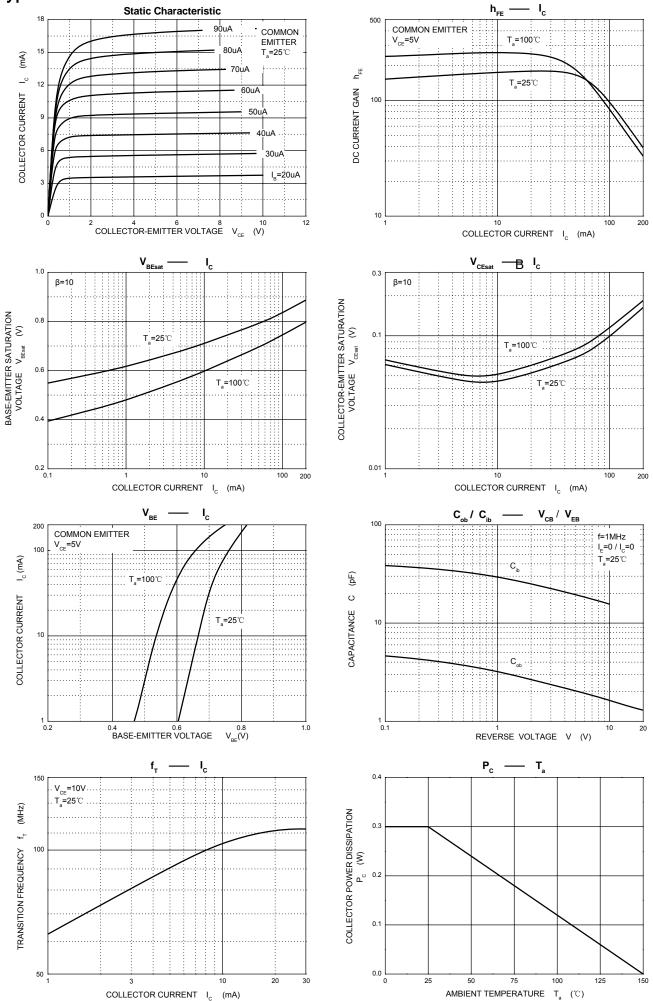
<sup>\*</sup>Pulse test: pulse width ≤300µs, duty cycle≤ 2.0%.

## CLASSIFICATION OF hfe (2)

RANK	L	Н
RANGE	100-200	200-300

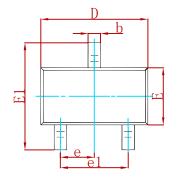


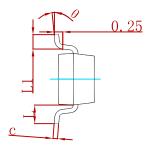
## **Typical Characteristics**

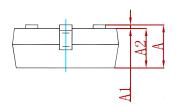




### PACKAGE MECHANICAL DATA

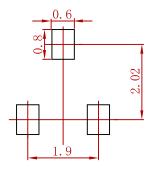






Cumbal	Dimensions	In Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950 TYP		0.037	7 TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022	REF	
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

## **Suggested Pad Layout**



#### Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
MMBT5551	SOT-23	3000



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